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Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of **Embedded - Microprocessors**

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details

Ξ·XF

Product Status	Active
Core Processor	PowerPC e500
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	667MHz
Co-Processors/DSP	Signal Processing; SPE
RAM Controllers	DDR, DDR2, SDRAM
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (2)
SATA	-
USB	-
Voltage - I/O	1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	-
Package / Case	783-BBGA, FCBGA
Supplier Device Package	783-FCPBGA (29x29)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mpc8544vtalfa

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



Figure 2 shows the undershoot and overshoot voltages at the interfaces of the MPC8544E.



Figure 2. Overshoot/Undershoot Voltage for GV_{DD}/OV_{DD}/LV_{DD}/BV_{DD}/TV_{DD}

The core voltage must always be provided at nominal 1.0 V (see Table 2 for actual recommended core voltage). Voltage to the processor interface I/Os are provided through separate sets of supply pins and must be provided at the voltages shown in Table 2. The input voltage threshold scales with respect to the associated I/O supply voltage. OV_{DD} and LV_{DD} based receivers are simple CMOS I/O circuits and satisfy appropriate LVCMOS type specifications. The DDR2 SDRAM interface uses a single-ended differential receiver referenced the externally supplied MV_{REF} signal (nominally set to $GV_{DD}/2$) as is appropriate for the SSTL2 electrical signaling standard.



DDR and DDR2 SDRAM

Table 12. DDR SDRAM DC Electrical Characteristics for GV_{DD}(typ) = 2.5 V (continued)

Parameter/Condition	Symbol	Min	Мах	Unit	Notes
Output low current (V _{OUT} = 0.42 V)	I _{OL}	16.2	_	mA	

Notes:

1. GV_{DD} is expected to be within 50 mV of the DRAM GV_{DD} at all times.

2. MV_{REF} is expected to be equal to 0.5 × GV_{DD} , and to track GV_{DD} DC variations as measured at the receiver. Peak-to-peak noise on MV_{REF} may not exceed ±2% of the DC value.

3. V_{TT} is not applied directly to the device. It is the supply to which far end signal termination is made and is expected to be equal to MV_{REF}. This rail should track variations in the DC level of MV_{REF}.

Table 13 provides the DDR I/O capacitance when $GV_{DD}(typ) = 2.5$ V.

Table 13. DDR SDRAM Capacitance for GV_{DD}(typ) = 2.5 V

Parameter/Condition	Symbol	Min	Max	Unit	Notes
Input/output capacitance: DQ, DQS	C _{IO}	6	8	pF	1
Delta input/output capacitance: DQ, DQS	C _{DIO}	_	0.5	pF	1

Note:

1. This parameter is sampled. $GV_{DD} = 2.5 \text{ V} \pm 0.125 \text{ V}$, f = 1 MHz, T_A = 25°C, V_{OUT} = $GV_{DD}/2$, V_{OUT} (peak-to-peak) = 0.2 V.

Table 14 provides the current draw characteristics for MV_{REF} .

Table 14. Current Draw Characteristics for MV_{REF}

Parameter/Condition	Symbol	Min	Max	Unit	Notes
Current draw for MV _{REF}	I _{MVREF}		500	μA	1

Note:

1. The voltage regulator for MV_{REF} must be able to supply up to 500 μ A current.

6.2 DDR SDRAM AC Electrical Characteristics

This section provides the AC electrical characteristics for the DDR SDRAM interface.

6.2.1 DDR SDRAM Input AC Timing Specifications

Table 15 provides the input AC timing specifications for the DDR SDRAM when $GV_{DD}(typ) = 1.8 V$.

Table 15. DDR2 SDRAM Input AC Timing Specifications for 1.8-V Interface

At recommended operating conditions.

Parameter	Symbol	Symbol Min		Unit	Notes
AC input low voltage	V _{IL}	—	MV _{REF} – 0.25	V	_
AC input high voltage	V _{IH}	MV _{REF} + 0.25	_	V	_



Table 33. MII Receive AC Timing Specifications (continued)

At recommended operating conditions with L/TVDD of 3.3 V \pm 5%.or 2.5 V \pm 5%.

Parameter/Condition	Symbol ¹	Min	Тур	Мах	Unit	Notes
RXD[3:0], RX_DV, RX_ER setup time to RX_CLK	t _{MRDVKH}	10.0	—	—	ns	—
RXD[3:0], RX_DV, RX_ER hold time to RX_CLK	t _{MRDXKH}	10.0	—	—	ns	—
RX_CLK clock rise (20%–80%)	t _{MRXR}	1.0	—	4.0	ns	—
RX_CLK clock fall time (80%–20%)	t _{MRXF}	1.0	—	4.0	ns	

Note:

1. The symbols used for timing specifications follow the pattern of t_{(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t_{(first two letters of functional block)(reference)(state)(signal)(state) for outputs. For example, t_{MRDVKH} symbolizes MII receive timing (MR) with respect to the time data input signals (D) reach the valid state (V) relative to the t_{MRX} clock reference (K) going to the high (H) state or setup time. Also, t_{MRDXKL} symbolizes MII receive timing (GR) with respect to the time data input signals (D) went invalid (X) relative to the t_{MRX} clock reference (K) going to the low (L) state or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t_{MRX} represents the MII (M) receive (RX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).}}

Figure 17 provides the AC test load for eTSEC.



Figure 17. eTSEC AC Test Load

Figure 18 shows the MII receive AC timing diagram.



Figure 18. MII Receive AC Timing Diagram

8.7 TBI AC Timing Specifications

This section describes the TBI transmit and receive AC timing specifications.



Parameter	Symbol	Min	Мах	Unit	Notes
High-level output voltage (BV _{DD} = min, I _{OH} = -2 mA)	V _{OH}	1.35	_	V	
Low-level output voltage (BV _{DD} = min, I _{OL} = 2 mA)	V _{OL}		0.45	V	

Table 44. Local Bus DC Electrical Characteristics (1.8 V DC) (continued)

10.2 Local Bus AC Electrical Specifications

Table 45 describes the general timing parameters of the local bus interface at $BV_{DD} = 3.3$ V. For information about the frequency range of local bus see Section 19.1, "Clock Ranges."

Parameter	Symbol ¹	Min	Мах	Unit	Notes
Local bus cycle time	t _{LBK}	7.5	12	ns	2
Local bus duty cycle	t _{LBKH/} t _{LBK}	43	57	%	—
LCLK[n] skew to LCLK[m] or LSYNC_OUT	t _{LBKSKEW}	—	150	ps	7, 8
Input setup to local bus clock (except LUPWAIT)	t _{LBIVKH1}	2.5	—	ns	3, 4
LUPWAIT input setup to local bus clock	t _{LBIVKH2}	1.85	—	ns	3, 4
Input hold from local bus clock (except LUPWAIT)	t _{LBIXKH1}	1.0	—	ns	3, 4
LUPWAIT input hold from local bus clock	t _{LBIXKH2}	1.0	—	ns	3, 4
LALE output transition to LAD/LDP output transition (LATCH setup and hold time)	t _{lbotot}	1.5	—	ns	6
Local bus clock to output valid (except LAD/LDP and LALE)	t _{LBKHOV1}	—	2.9	ns	—
Local bus clock to data valid for LAD/LDP	t _{LBKHOV2}	—	2.8	ns	—
Local bus clock to address valid for LAD	t _{LBKHOV3}	—	2.7	ns	3
Local bus clock to LALE assertion	t _{LBKHOV4}	—	2.7	ns	3
Output hold from local bus clock (except LAD/LDP and LALE)	t _{LBKHOX1}	0.7	—	ns	3
Output hold from local bus clock for LAD/LDP	t _{LBKHOX2}	0.7	_	ns	3
Local bus clock to output high Impedance (except LAD/LDP and LALE)	t _{LBKHOZ1}	—	2.5	ns	5

Table 45. Local Bus General Timing Parameters (BV_{DD} = 3.3 V)—PLL Enabled



JTAG

12 JTAG

This section describes the AC electrical specifications for the IEEE 1149.1 (JTAG) interface of the MPC8544E.

12.1 JTAG DC Electrical Characteristics

Table 49 provides the DC electrical characteristics for the JTAG interface.

Table 49. JTAG DC Electrical Characteristics

Parameter	Symbol	Min	Мах	Unit	Notes
High-level input voltage	V _{IH}	2	OV _{DD} + 0.3	V	
Low-level input voltage	V _{IL}	-0.3	0.8	V	
Input current (OV _{IN} = 0 V or OV _{IN} = OV _{DD})	I _{IN}	—	±5	μA	1
High-level output voltage ($OV_{DD} = min, I_{OH} = -2 mA$)	V _{OH}	2.4	—	V	_
Low-level output voltage ($OV_{DD} = min, I_{OL} = 2 mA$)	V _{OL}	—	0.4	V	_

Note:

1. Note that the symbol V_{IN} , in this case, represents the OV_{IN} .

12.2 JTAG AC Electrical Specifications

Table 50 provides the JTAG AC timing specifications as defined in Figure 34 through Figure 37.

Table 50. JTAG AC Timing Specifications (Independent of SYSCLK)¹

At recommended operating conditions (see Table 3).

Parameter	Symbol ²	Min	Max	Unit	Notes
JTAG external clock frequency of operation	f _{JTG}	0	33.3	MHz	—
JTAG external clock cycle time	t _{JTG}	30	_	ns	—
JTAG external clock pulse width measured at 1.4 V	t _{JTKHKL}	15	—	ns	—
JTAG external clock rise and fall times	t _{JTGR} & t _{JTGF}	0	2	ns	—
TRST assert time	t _{TRST}	25	—	ns	3
Input setup times: Boundary-scan data TMS, TDI	t _{JTDVKH} t _{JTIVKH}	4 0		ns	4
Input hold times: Boundary-scan data TMS, TDI	t _{JTDXKH} t _{JTIXKH}	20 25	_	ns	4
Valid times: Boundary-scan data TDO	t _{JTKLDV} t _{JTKLOV}	4 4	20 25	ns	5
Output hold times: Boundary-scan data TDO	t _{jtkldx} t _{jtklox}	2.5 4		ns	5



High-Speed Serial Interfaces (HSSI)



Figure 54. Single-Ended Measurement Points for Rise and Fall Time Matching

The other detailed AC requirements of the SerDes reference clocks is defined by each interface protocol based on application usage. Refer to the following sections for detailed information:

- Section 8.3.1, "The DBWO Signal"
- Section 17.2, "AC Requirements for PCI Express SerDes Clocks"

16.2.4.1 Spread Spectrum Clock

SD1_REF_CLK/SD1_REF_CLK were designed to work with a spread spectrum clock (+0 to -0.5% spreading at 30–33 kHz rate is allowed), assuming both ends have same reference clock. For better results, a source without significant unintended modulation should be used.

SD2_REF_CLK/SD2_REF_CLK are not intended to be used with, and should not be clocked by, a spread spectrum clock source.

16.3 SerDes Transmitter and Receiver Reference Circuits

Figure 55 shows the reference circuits for SerDes data lane's transmitter and receiver.



Figure 55. SerDes Transmitter and Receiver Reference Circuits

The DC and AC specification of SerDes data lanes are defined in the section below (PCI Express or SGMII) in this document based on the application usage:

- Section 8.3, "SGMII Interface Electrical Characteristics"
- Section 17, "PCI Express"

Please note that external AC Coupling capacitor is required for the above serial transmission protocols with the capacitor value defined in specification of each protocol section.



17 PCI Express

This section describes the DC and AC electrical specifications for the PCI Express bus of the MPC8544.

17.1 DC Requirements for PCI Express SD_REF_CLK and SD_REF_CLK

For more information, see Section 16.2, "SerDes Reference Clocks."

17.2 AC Requirements for PCI Express SerDes Clocks

Table 58 provides the AC requirements for the PCI Express SerDes clocks.

Symbol ²	Parameter Description		Тур	Max	Units	Notes
t _{REF}	REFCLK cycle time	_	10	_	ns	1
t _{REFCJ}	REFCLK cycle-to-cycle jitter. Difference in the period of any two adjacent REFCLK cycles			100	ps	
t _{REFPJ}	Phase jitter. Deviation in edge location with respect to mean edge location		—	50	ps	—

Table 58. SD_REF_CLK and SD_REF_CLK AC Requirements

Notes:

1. Typical based on PCI Express Specification 2.0.

2. Guaranteed by characterization.

17.3 Clocking Dependencies

The ports on the two ends of a link must transmit data at a rate that is within 600 parts per million (ppm) of each other at all times. This is specified to allow bit rate clock sources with a ± 300 ppm tolerance.

17.4 Physical Layer Specifications

The following is a summary of the specifications for the physical layer of PCI Express on this device. For further details as well as the specifications of the transport and data link layer please refer to the *PCI Express Base Specification. Rev. 1.0a.*



17.4.1 Differential Transmitter (TX) Output

Table 59 defines the specifications for the differential output at all transmitters. The parameters are specified at the component pins.

Symbol	Parameter	Min	Nom	Max	Unit	Comments
UI	Unit interval	399.88	400	400.12	ps	Each UI is 400 ps ± 300 ppm. UI does not account for Spread Spectrum Clock dictated variations. See Note 1.
V _{TX-DIFFp-p}	Differential peak-to- peak output voltage	0.8		1.2	V	$V_{TX-DIFFp-p} = 2^{*}IV_{TX-D+} - V_{TX-D-}I.$ See Note 2.
V _{TX-DE-RATIO}	De- emphasized differential output voltage (ratio)	-3.0	-3.5	-4.0	dB	Ratio of the $V_{TX-DIFFp-p}$ of the second and following bits after a transition divided by the $V_{TX-DIFFp-p}$ of the first bit after a transition. See Note 2.
T _{TX-EYE}	Minimum TX eye width	0.70		—	UI	The maximum transmitter jitter can be derived as $T_{TX-MAX-JITTER} = 1 - T_{TX-EYE} = 0.3$ UI. See Notes 2 and 3.
T _{TX-EYE-MEDIAN-to-} MAX-JITTER	Maximum time between the jitter median and maximum deviation from the median.			0.15	UI	Jitter is defined as the measurement variation of the crossing points ($V_{TX-DIFFp-p}$ = 0 V) in relation to a recovered TX UI. A recovered TX UI is calculated over 3500 consecutive unit intervals of sample data. Jitter is measured using all edges of the 250 consecutive UI in the center of the 3500 UI used for calculating the TX UI. See Notes 2 and 3.
T _{TX-RISE} , T _{TX-FALL}	D+/D- TX output rise/fall time	0.125	_	_	UI	See Notes 2 and 5.
V _{TX-CM-ACp}	RMS AC peak common mode output voltage		_	20	mV	$\begin{split} & V_{TX-CM-ACp} = RMS(IV_{TXD+} - \\ & V_{TXD-}I/2 - V_{TX-CM-DC}) \\ & V_{TX-CM-DC} = DC_{(avg)} \text{ of } IV_{TX-D+} - \\ & V_{TX-D-}I/2 \\ & See Note 2. \end{split}$
V _{TX-CM-DC-ACTIVE-} IDLE-DELTA	Absolute delta of DC common mode voltage during LO and electrical idle	0		100	mV	$\begin{split} & V_{TX-CM-DC \ (during \ LO)} - V_{TX-CM-Idle-DC} \\ &(During \ Electrical \ Idle) <= 100 \ mV \\ &V_{TX-CM-DC} = DC_{(avg)} \ of \ V_{TX-D+} - \\ &V_{TX-D-} /2 \ [LO] \\ &V_{TX-CM-Idle-DC} = DC_{(avg)} \ of \ V_{TX-D+} - \\ &V_{TX-D-} /2 \ [Electrical \ Idle] \\ &See \ Note \ 2. \end{split}$
VTX-CM-DC-LINE-DELTA	Absolute delta of DC common mode between D+ and D–	0	_	25	mV	$\begin{split} V_{\text{TX-CM-DC-D+}} - V_{\text{TX-CM-DC-D-}} &<= 25 \text{ mV} \\ V_{\text{TX-CM-DC-D+}} = DC_{(avg)} \text{ of } V_{\text{TX-D+}} \\ V_{\text{TX-CM-DC-D-}} = DC_{(avg)} \text{ of } V_{\text{TX-D-}} \\ \text{See Note 2.} \end{split}$
V _{TX-IDLE} -DIFFp	Electrical idle differential peak output voltage	0		20	mV	$V_{TX-IDLE-DIFFp} = IV_{TX-IDLE-D+} - V_{TX-IDLE-D-}$ <= 20 mV See Note 2.

Table 59. Differential Transmitter (TX) Output Specifications







17.4.3 Differential Receiver (RX) Input Specifications

Table 60 defines the specifications for the differential input at all receivers. The parameters are specified at the component pins.

Symbol	Parameter	Min	Nom	Max	Units	Comments
UI	Unit interval	399.88	400	400.12	ps	Each UI is 400 ps ± 300 ppm. UI does not account for spread spectrum clock dictated variations. See Note 1.
V _{RX-DIFFp-p}	Differential peak-to- peak input voltage	0.175	_	1.200	V	$V_{RX-DIFFp-p} = 2 \times V_{RX-D+} - V_{RX-D-} $ See Note 2.
T _{RX-EYE}	Minimum receiver eye width	0.4			UI	The maximum interconnect media and transmitter jitter that can be tolerated by the receiver can be derived as $T_{RX-MAX-JITTER} = 1 - T_{RX-EYE} = 0.6$ UI. See Notes 2 and 3.

Table 60. Differential Receiver (RX) Input Specifications



Package Description

18.2 Mechanical Dimensions of the MPC8544E FC-PBGA

Figure 59 shows the mechanical dimensions and bottom surface nomenclature of the MPC8544E, 783 FC-PBGA package without a lid.



Notes:

- 1. All dimensions are in millimeters.
- 2. Dimensions and tolerances per ASME Y14.5M-1994.
- 3. Maximum solder ball diameter measured parallel to datum A.
- 4. Datum A, the seating plane, is determined by the spherical crowns of the solder balls.
- 5. Parallelism measurement shall exclude any effect of mark on top surface of package.
- 6. Capacitors may not be present on all parts. Care must be taken not to short exposed metal capacitor pads.
- 7. All dimensions are symmetric across the package center lines, unless dimensioned otherwise.

Figure 59. Mechanical Dimensions and Bottom Surface Nomenclature of the MPC8544E FC-PBGA without a Lid



Signal	Package Pin Number	Pin Type	Power Supply	Notes
LCS6/DMA_DACK2	J16	0	BV _{DD}	1
LCS7/DMA_DDONE2	L18	0	BV _{DD}	1
LWE0/LBS0/LSDDQM[0]	J22	0	BV _{DD}	4, 8
LWE1/LBS1/LSDDQM[1]	H22	0	BV _{DD}	4, 8
LWE2/LBS2/LSDDQM[2]	H23	0	BV _{DD}	4, 8
LWE3/LBS3/LSDDQM[3]	H21	0	BV _{DD}	4, 8
LALE	J26	0	BV _{DD}	4, 7, 8
LBCTL	J25	0	BV _{DD}	4, 7, 8
LGPL0/LSDA10	J20	0	BV _{DD}	4, 8
LGPL1/LSDWE	К20	0	BV _{DD}	4, 8
LGPL2/LOE/LSDRAS	G20	0	BV _{DD}	4, 7, 8
LGPL3/LSDCAS	H18	0	BV _{DD}	4, 8
LGPL4/LGTA/LUPWAIT/ LPBSE	L20	I/O	BV _{DD}	28
LGPL5	К19	0	BV _{DD}	4, 8
LCKE	L17	0	BV _{DD}	—
LCLK[0:2]	H24, J24, H25	0	BV _{DD}	—
LSYNC_IN	D27	I	BV _{DD}	—
LSYNC_OUT	D28	0	BV _{DD}	—
	DMA			
DMA_DACK[0:1]	Y13, Y12	0	OV _{DD}	4, 8, 9
DMA_DREQ[0:1]	AA10, AA11	I	OV _{DD}	—
DMA_DDONE[0:1]	AA7, Y11	0	OV _{DD}	—
	Programmable Interrupt Contro	oller		·
UDE	AH15	I	OV _{DD}	—
MCP	AG18	I	OV _{DD}	—
IRQ[0:7]	AG22, AF17, AD21, AF19, AG17, AF16, AC23, AC22	I	OV _{DD}	_
IRQ[8]	AC19	I	OV _{DD}	—
IRQ[9]/DMA_DREQ3	AG20	I	OV _{DD}	1
IRQ[10]/DMA_DACK3	AE27	I/O	OV _{DD}	1
IRQ[11]/DMA_DDONE3	AE24	I/O	OV _{DD}	1
IRQ_OUT	AD14	0	OV _{DD}	2

Table 62. MPC8544E Pinout Listing (continued)



Package Description

Table 62. MPC8544E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes		
	Ethernet Management Interfa	ce		•		
EC_MDC	AC7	0	OV _{DD}	4, 8, 14		
EC_MDIO	Y9	I/O	OV _{DD}	—		
	Gigabit Reference Clock	·				
EC_GTX_CLK125	Т2	I	LV _{DD}	—		
Three-Speed Ethernet Controller (Gigabit Ethernet 1)						
TSEC1_RXD[7:0]	U10, U9, T10, T9, U8, T8, T7, T6	I	LV _{DD}	—		
TSEC1_TXD[7:0]	T5, U5, V5, V3, V2, V1, U2, U1	0	LV _{DD}	4, 8, 14		
TSEC1_COL	R5	I	LV _{DD}	—		
TSEC1_CRS	Τ4	I/O	LV _{DD}	16		
TSEC1_GTX_CLK	Т1	0	LV _{DD}	—		
TSEC1_RX_CLK	V7	I	LV _{DD}	—		
TSEC1_RX_DV	U7	I	LV _{DD}	—		
TSEC1_RX_ER	R9	I	LV _{DD}	4, 8		
TSEC1_TX_CLK	V6	I	LV _{DD}	—		
TSEC1_TX_EN	U4	0	LV _{DD}	22		
TSEC1_TX_ER	ТЗ	0	LV _{DD}	—		
	Three-Speed Ethernet Controller (Gigab	it Ethernet 3)				
TSEC3_RXD[7:0]	P11, N11, M11, L11, R8, N10, N9, P10	I	LV _{DD}	—		
TSEC3_TXD[7:0]	M7, N7, P7, M8, L7, R6, P6, M6	0	LV _{DD}	4, 8, 14		
TSEC3_COL	M9	I	LV _{DD}	—		
TSEC3_CRS	L9	I/O	LV _{DD}	16		
TSEC3_GTX_CLK	R7	0	LV _{DD}	—		
TSEC3_RX_CLK	Р9	I	LV _{DD}	—		
TSEC3_RX_DV	P8	I	LV _{DD}	—		
TSEC3_RX_ER	R11	I	LV _{DD}	—		
TSEC3_TX_CLK	L10	I	LV _{DD}	—		
TSEC3_TX_EN	N6	0	LV _{DD}	22		
TSEC3_TX_ER	L8	0	LV _{DD}	4, 8		
	DUART					
UART_CTS[0:1]	AH8, AF6	I	OV _{DD}	_		
UART_RTS[0:1]	AG8, AG9	0	OV _{DD}	—		



Table 62. MPC8544E Pinout Listing (continued	Table 62	. MPC8544E	Pinout	Listing	(continued
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Signal	Package Pin Number	Pin Type	Power Supply	Notes
UART_SIN[0:1]	AG7, AH6	I	OV _{DD}	—
UART_SOUT[0:1]	AH7, AF7	0	OV _{DD}	
	I ² C interface			•
IIC1_SCL	AG21	I/O	OV _{DD}	20
IIC1_SDA	AH21	I/O	OV _{DD}	20
IIC2_SCL	AG13	I/O	OV _{DD}	20
IIC2_SDA	AG14	I/O	OV _{DD}	20
	SerDes 1			
SD1_RX[0:7]	N28, P26, R28, T26, Y26, AA28, AB26, AC28	I	XV _{DD}	_
SD1_RX[0:7]	N27, P25, R27, T25, Y25, AA27, AB25, AC27	I	XV _{DD}	
SD1_TX[0:7]	M23, N21, P23, R21, U21, V23, W21, Y23	0	XV _{DD}	
SD1_TX[0:7]	M22, N20, P22, R20, U20, V22, W20, Y22	0	XV _{DD}	
SD1_PLL_TPD	V28	0	XV _{DD}	17
SD1_REF_CLK	U28	I	XV _{DD}	_
SD1_REF_CLK	U27	I	XV _{DD}	_
SD1_TST_CLK	T22		—	—
SD1_TST_CLK	Т23		—	—
	SerDes 2			
SD2_RX[0]	AD25	I	xv _{DD}	—
SD2_RX[2]	AD1	I	xv _{DD}	26
SD2_RX[3]	AB2	I	XV _{DD}	26
SD2_RX[0]	AD26	I	XV _{DD}	—
SD2_RX[2]	AC1	I	XV _{DD}	26
SD2_RX[3]	AA2	I	XV _{DD}	26
SD2_TX[0]	AA21	0	XV _{DD}	—
SD2_TX[2]	AC4	0	xv _{DD}	26
SD2_TX[3]	AA5	0	XV _{DD}	26
SD2_TX[0]	AA20	0	XV _{DD}	—
SD2_TX[2]	AB4	0	XV _{DD}	26
SD2_TX[3]	Y5	0	XV _{DD}	26
SD2_PLL_TPD	AG3	0	XV _{DD}	17
SD2_REF_CLK	AE2	I	XV _{DD}	—



Clocking

Note that there is no default for this PLL ratio; these signals must be pulled to the desired values. Also note that the DDR data rate is the determining factor in selecting the CCB bus frequency, since the CCB frequency must equal the DDR data rate.

Binary Value of LA[28:31] Signals	CCB:SYSCLK Ratio	Binary Value of LA[28:31] Signals	CCB:SYSCLK Ratio
0000	16:1	1000	8:1
0001	Reserved	1001	9:1
0010	Reserved	1010	10:1
0011	3:1	1011	Reserved
0100	4:1	1100	12:1
0101	5:1	1101	Reserved
0110	6:1	1110	Reserved
0111	Reserved	1111	Reserved

Table	65.	ССВ	Clock	Ratio
Table	00.	000	Olock	nauo

19.3 e500 Core PLL Ratio

Table 66 describes the clock ratio between the e500 core complex bus (CCB) and the e500 core clock. This ratio is determined by the binary value of LBCTL, LALE, and LGPL2 at power up, as shown in Table 66.

Table 6	6. e500	Core to	ССВ	Clock Ratio
	0.0000			

Binary Value of LBCTL, LALE, LGPL2 Signals	e500 core:CCB Clock Ratio	Binary Value of LBCTL, LALE, LGPL2 Signals	e500 core:CCB Clock Ratio
000	4:1	100	2:1
001	Reserved	101	5:2
010	Reserved	110	3:1
011	3:2	111	7:2

19.4 PCI Clocks

For specifications on the PCI_CLK, refer to the PCI 2.2 Local Bus Specifications.

The use of PCI_CLK is optional if SYSCLK is in the range of 33–66 MHz. If SYSCLK is outside this range then use of PCI_CLK is required as a separate PCI clock source, asynchronous with respect to SYSCLK.



19.5 Security Controller PLL Ratio

Table 67 shows the SEC frequency ratio.

Table 67. SEC Frequency Ratio

Signal Name	Value (Binary)	CCB CLK:SEC CLK
LWE_B	0	2:1 ¹
	1	3:1 ²

Notes:

1. In 2:1 mode the CCB frequency must be operating ≤ 400 MHz.

2. In 3:1 mode any valid CCB can be used. The 3:1 mode is the default ratio for security block.

19.6 Frequency Options

19.6.1 SYSCLK to Platform Frequency Options

Table 68 shows the expected frequency values for the platform frequency when using a CCB clock to SYSCLK ratio in comparison to the memory bus clock speed.

CCB to SYSCLK Ratio	SYSCLK (MHz)						
	33.33	41.66	66.66	83	100	111	133.33
		·	Platform	CCB Freque	ncy (MHz)	·	
2							
3					—	333	400
4			—	333	400	445	533
5			333	415	500		
6			400	500		-	
8		333	533		-		
9		375					
10	333	417					
12	400	500					
16	533		-				

 Table 68. Frequency Options of SYSCLK with Respect to Memory Bus Speeds



19.6.2 Platform to FIFO Restrictions

Please note the following FIFO maximum speed restrictions based on platform speed. Refer to Section 4.4, "Platform to FIFO Restrictions," for additional information.

Platform Speed (MHz)	Maximum FIFO Speed for Reference Clocks TSEC <i>n</i> _TX_CLK, TSEC <i>n</i> _RX_CLK (MHz) ¹
533	126
400	94

Table 69. FIFO Maximum Speed Restrictions

Note:

1. FIFO speed should be less than 24% of the platform speed.

20 Thermal

This section describes the thermal specifications of the MPC8544E.

20.1 Thermal Characteristics

Table 70 provides the package thermal characteristics.

 Table 70. Package Thermal Characteristics

Characteristic	JEDEC Board Symbol		Value	Unit	Notes
Junction-to-ambient natural convection	Single layer board (1s)	R_{\thetaJA}	26	°C/W	1, 2
Junction-to-ambient natural convection	Four layer board (2s2p)	$R_{ extsf{ heta}JA}$	21	°C/W	1, 2
Junction-to-ambient (@200 ft/min)	Single layer board (1s)	$R_{ extsf{ heta}JA}$	21	°C/W	1, 2
Junction-to-ambient (@200 ft/min)	Four layer board (2s2p)	$R_{ extsf{ heta}JA}$	17	°C/W	1, 2
Junction-to-board thermal	—	$R_{ extsf{ heta}JB}$	12	°C/W	3
Junction-to-case thermal	_	R_{\thetaJC}	<0.1	°C/W	4

Notes:

1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, airflow, power dissipation of other components on the board, and board thermal resistance.

2. Per JEDEC JESD51-2 and JESD51-6 with the board (JESD51-9) horizontal.

3. Thermal resistance between the die and the printed-circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.

4. Thermal resistance between the active surface of the die and the case top surface determined by the cold plate method (MIL SPEC-883 Method 1012.1) with the calculated case temperature. Actual thermal resistance is less than 0.1°C/W.



Thermal

Heat sinks are attached to the package by means of a spring clip to holes in the printed-circuit board (see Figure 61). Therefore, the synthetic grease offers the best thermal performance, especially at the low interface pressure.



Figure 63. Thermal Performance of Select Thermal Interface Materials

The system board designer can choose between several types of thermal interface. There are several commercially-available thermal interfaces provided by the following vendors:

Chomerics, Inc. 781-935-4850 77 Dragon Ct. Woburn, MA 01801 Internet: www.chomerics.com Dow-Corning Corporation800-248-2481 Corporate Center P.O.Box 999 Midland, MI 48686-0997 Internet: www.dow.com Shin-Etsu MicroSi, Inc.888-642-7674 10028 S. 51st St. Phoenix, AZ 85044 Internet: www.microsi.com The Bergquist Company800-347-4572 18930 West 78th St.



resistance of the pull-up devices. R_P and R_N are designed to be close to each other in value. Then, $Z_0 = (R_P + R_N) \div 2$.



Figure 67. Driver Impedance Measurement

Table 73 summarizes the signal impedance targets. The driver impedances are targeted at minimum V_{DD} , nominal OV_{DD} , 90°C.

 Table 73. Impedance Characteristics

Impedance	Local Bus, Ethernet, DUART, Control, Configuration, Power Management	PCI	DDR DRAM	Symbol	Unit
R _N	43 Target	25 Target	20 Target	Z ₀	W
R _P	43 Target	25 Target	20 Target	Z ₀	W

Note: Nominal supply voltages. See Table 1.

21.8 Configuration Pin Muxing

The MPC8544E provides the user with power-on configuration options which can be set through the use of external pull-up or pull-down resistors of 4.7 k Ω on certain output pins (see customer visible configuration pins). These pins are generally used as output only pins in normal operation.

While $\overline{\text{HRESET}}$ is asserted however, these pins are treated as inputs. The value presented on these pins while $\overline{\text{HRESET}}$ is asserted, is latched when $\overline{\text{HRESET}}$ deasserts, at which time the input receiver is disabled and the I/O circuit takes on its normal function. Most of these sampled configuration pins are equipped with an on-chip gated resistor of approximately 20 kΩ. This value should permit the 4.7-kΩ resistor to pull the configuration pin to a valid logic low level. The pull-up resistor is enabled only during $\overline{\text{HRESET}}$ (and for platform /system clocks after $\overline{\text{HRESET}}$ deassertion to ensure capture of the reset value). When the input receiver is disabled the pull-up is also, thus allowing functional operation of the pin as an output with minimal signal quality or delay disruption. The default value for all configuration bits treated this way has



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been encoded such that a high voltage level puts the device into the default state and external resistors are needed only when non-default settings are required by the user.

Careful board layout with stubless connections to these pull-down resistors coupled with the large value of the pull-down resistor should minimize the disruption of signal quality or speed for output pins thus configured.

The platform PLL ratio and e500 PLL ratio configuration pins are not equipped with these default pull-up devices.

21.9 JTAG Configuration Signals

Correct operation of the JTAG interface requires configuration of a group of system control pins as demonstrated in Figure 69. Care must be taken to ensure that these pins are maintained at a valid deasserted state under normal operating conditions as most have asynchronous behavior and spurious assertion will give unpredictable results.

Boundary-scan testing is enabled through the JTAG interface signals. The TRST signal is optional in the IEEE 1149.1 specification, but is provided on all processors built on Power ArchitectureTM technology. The device requires TRST to be asserted during reset conditions to ensure the JTAG boundary logic does not interfere with normal chip operation. While it is possible to force the TAP controller to the reset state using only the TCK and TMS signals, generally systems will assert TRST during the power-on reset flow. Simply tying TRST to HRESET is not practical because the JTAG interface is also used for accessing the common on-chip processor (COP) function.

The COP function of these processors allow a remote computer system (typically, a PC with dedicated hardware and debugging software) to access and control the internal operations of the processor. The COP interface connects primarily through the JTAG port of the processor, with some additional status monitoring signals. The COP port requires the ability to independently assert HRESET or TRST in order to fully control the processor. If the target system has independent reset sources, such as voltage monitors, watchdog timers, power supply failures, or push-button switches, then the COP reset signals must be merged into these signals with logic. The arrangement shown in Figure 69 allows the COP port to independently assert HRESET or TRST, while ensuring that the target can drive HRESET as well.

The COP interface has a standard header, shown in Figure 68, for connection to the target system, and is based on the 0.025" square-post, 0.100" centered header assembly (often called a Berg header). The connector typically has pin 14 removed as a connector key.

The COP header adds many benefits such as breakpoints, watchpoints, register and memory examination/modification, and other standard debugger features. An inexpensive option can be to leave the COP header unpopulated until needed.

There is no standardized way to number the COP header; consequently, many different pin numbers have been observed from emulator vendors. Some are numbered top-to-bottom then left-to-right, while others use left-to-right then top-to-bottom, while still others number the pins counter clockwise from pin 1 (as with an IC). Regardless of the numbering, the signal placement recommended in Figure 68 is common to all known emulators.



22.2 Nomenclature of Parts Fully Addressed by this Document

Table 75 provides the Freescale part numbering nomenclature for the MPC8544E.

Table 75. Device Nomenclature

MPC	nnnn	Ε	С	НХ	AA	X	В
Product Code	Part Identifier	Encryption Acceleration	Temperature Range	Package ¹	Processor Frequency ²	Platform Frequency	Revision Level
MPC	8544	Blank = not included E = included	B or Blank = Industrial Tier standard temp range(0° to 105°C) C = Industrial Tier Extended temp range(-40° to 105°C)	VT = FC-PBGA (lead-free) VJ = lead-free FC-PBGA	AL = 667 MHz AN = 800 MHz AQ = 1000 MHz AR = 1067 MHz	F = 333 MHz G = 400 MHz J = 533 MHz	Blank = Rev. 1.1 1.1.1 A = Rev. 2.1

Notes:

- 1. See Section 18, "Package Description," for more information on available package types.
- Processor core frequencies supported by parts addressed by this specification only. Not all parts described in this specification support all core frequencies. Additionally, parts addressed by part number specifications may support other maximum core frequencies.
- 3. The VT part number is ROHS-compliant, with the permitted exception of the C4 die bumps.
- 4. The VJ part number is entirely lead-free. This includes the C4 die bumps.

22.3 Part Marking

Parts are marked as in the example shown in Figure 70.



Notes:

MMMMM is the 5-digit mask number.

ATWLYYWW is the traceability code.

CCCCC is the country of assembly. This space is left blank if parts are assembled in the United States.

Figure 70. Part Marking for FC-PBGA Device